

Search Notes

Application/Control No.

10/840,241

Examiner

James W. Cranson

Applicant(s)/Patent under
Reexamination

CHIOU, YI-SHIUAN

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	600-634	11/3/2005	JWC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text 362/600-634.ccls	11/3/2005	JWC
EAST (ALL SEVEN DATA BASES)	11/3/2005	JWC